			Application/Control No.		Applicant(s)/Pat	Applicant(s)/Patent under Reexamination	ition
) enssj	Issue Classification	_	09838678		UHT ET AL.		
			Examiner		Art Unit		
			Li, Aimee J		2183		
	ORIGINAL	INAL		2	INTERNATIONAL CLASSIFICATION	CLASSIFICATIO	N
CL	CLASS		SUBCLASS	CC	CLAIMED	NON-CLAIMED	AIMED
712		226		9 0 9	F 15 / 00		
	CROSS REFERENCE(S)	ERENCE	(S)				
CLASS	SUBCLASS (ONE SUBCLASS	NE SUBCI	ASS PER BLOCK)				
			. ,				
(Assistant Examiner)	10/30 (Date	10/30/2006 (Date)				Total Claims Allowed:	s Allowed:
(Legal Instruments Examiner)	uminer) (Date)	(;	4DDIE CHAN SUPERVISORY PATENT EXAMINER (Primary EXECRANOLOGY CENTER 2100(Date)		79/08/01	O.G. Print Claim(s) 1	O.G. Print Figure 2

U.S. Patent and Trademark Office

Part of Paper No. 20060831